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| Notice of References Cited | Application/Control No. 10/764,483 | | Applicant(s)/Patent Under Reexamination LEE, GUN-IL | |
| | Examiner Allen H. Nguyen | | Art Unit 2625 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-6,385,728 | 05-2002 | DeBry, Roger K. | 726/9 |
| * | B | US-2002/0016833 | 02-2002 | Yajima et al. | 709/220 |
| * | C | US-7,304,755 | 12-2007 | Baba, Keizo | 358/1.15 |
| * | D | US-5,005,200 | 04-1991 | Fischer, Addison M. | 380/30 |
| * | E | US-5,633,932 | 05-1997 | Davis et al. | 713/176 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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